Vishay Siliconix

N-Channel 100 V (D-S) MOSFET



PRODUCT SUMMARY						
V _{DS} (V)	100					
$R_{DS(on)}$ max. (Ω) at V_{GS} = 10 V	0.0100					
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 7.5 \text{ V}$	0.0106					
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 6 \text{ V}$	0.0113					
Q _g typ. (nC)	28					
I _D (A) ^a	18.7					
Configuration	Single					

FEATURES

- TrenchFET® power MOSFET
- 100 % R_g and UIS tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

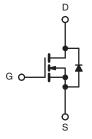


HALOGEN

FREE

APPLICATIONS

- DC/DC primary side switch
- Telecom / server
- Motor drive control
- Synchronous rectification



N-Channel MOSFET

ORDERING INFORMATION			
Package	SO-8		
Lead (Pb)-free and halogen-free	SI4090BDY-T1-GE3		

PARAMETER		SYMBOL	LIMIT	UNIT
Drain-source voltage		V _{DS}	100	V
Gate-source voltage		V _{GS}	± 20	V
	T _C = 25 °C		18.7	
Continuous drain surrent /T 150 °C\	T _C = 70 °C		15	
Continuous drain current (T _J = 150 °C)	T _A = 25 °C	I _D	12.2 ^{b, c}	
	T _A = 70 °C		9.8 b, c	
Pulsed drain current (t = 300 μs)		I _{DM}	80	A
Continuous source-drain diode current	T _C = 25 °C		6.7	
	T _A = 25 °C	I _S	2.8 b, c	
Single pulse avalanche current	. 0.1!!	I _{AS}	35	
Avalanche energy	L = 0.1 mH	E _{AS}	61.25	mJ
Maximum power dissipation	T _C = 25 °C		7.4	
	T _C = 70 °C		4.7	347
	T _A = 25 °C	P _D	3.1 b, c	W
	T _A = 70 °C		2.0 b, c	
Operating junction and storage temperature range		T _J , T _{sta}	-55 to +150	°C

THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT		
Maximum junction-to-ambient b, d	t ≤ 10 s	R_{thJA}	33	40	°C/W	
Maximum junction-to-foot (drain)	Steady state	R_{thJF}	15	17	0/44	

Notes

- a. Based on T_C = 25 °C
- b. Surface mounted on 1" x 1" FR4 board
- c. t = 10 s
- d. Maximum under steady state conditions is 90 °C/W

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PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static			•				
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	I _D = 10 mA	-	70	-	mV/°C	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-7.6	-		
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2	-	4	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA	
		V _{DS} = 100 V, V _{GS} = 0 V	-	-	1		
Zero gate voltage drain current	I _{DSS}	V _{DS} = 100 V, V _{GS} = 0 V, T _J = 55 °C	-	-	10	μΑ	
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	20	-	-	Α	
	, , , , , , , , , , , , , , , , , , ,	V _{GS} = 10 V, I _D = 12.2 A	-	0.0084	0.0100	Ω	
Drain-source on-state resistance a	R _{DS(on)}	V _{GS} = 7.5 V, I _D = 11.8 A	-	0.0088	0.0106		
	= =(=:,)	V _{GS} = 6 V, I _D = 11.5 A	-	0.0094	0.0113		
Forward transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 12.2 A	-	98	-	S	
Dynamic ^b			L		L	L	
Input capacitance	C _{iss}		_	3570	-	pF	
Output capacitance	Coss	V _{DS} = 50 V, V _{GS} = 0 V, f = 1 MHz	-	250	-		
Reverse transfer capacitance	C _{rss}		-	10	-		
		$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 12.2 \text{ A}$	-	46.5	70	nC	
Total gate charge	Q_g	B6 44 7 46 4 7 B	-	28	42		
Gate-source charge	Q _{gs}	$V_{DS} = 50 \text{ V}, V_{GS} = 6 \text{ V}, I_{D} = 12.2 \text{ A}$	-	17	-		
Gate-drain charge	Q _{gd}		-	5	-		
Gate resistance	R _g	f = 1 MHz	0.12	0.6	1.2	Ω	
Turn-on delay time	t _{d(on)}		-	18	36		
Rise time	t _r	$V_{DD} = 50 \text{ V}, R_{L} = 5 \Omega$	-	6	12	1	
Turn-off delay time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 7.5 \text{ V}, R_g = 1 \Omega$	_	30	60		
Fall time	t _f		-	8	16		
Turn-on delay time	t _{d(on)}		-	22	44	ns	
Rise time	t _r	$V_{DD} = 50 \text{ V}, R_1 = 5 \Omega$	_	8	16	-	
Turn-off delay time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	32	64		
Fall time	t _f		-	10	20		
Drain-source Body Diode Characteristi	cs	l	l		I	I	
Continuous source-drain diode current	Is	T _C = 25 °C	_	-	7		
Pulse diode forward current ^a	I _{SM}		-	-	70	Α	
Body diode voltage	V _{SD}	I _S = 5 A	-	0.75	1.1	V	
Body diode reverse recovery time	t _{rr}		-	44	88	ns	
Body diode reverse recovery charge	Q _{rr}	l _F = 10 A, di/dt = 100 A/μs,	-	90	180	nC	
Reverse recovery fall time	t _a	$T_{J} = 25 ^{\circ}\text{C}$	_	37	-		
	-a	1	Ì	1	1	ns	

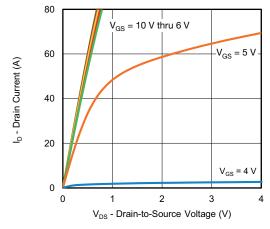
Notes

- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %
- b. Guaranteed by design, not subject to production testing

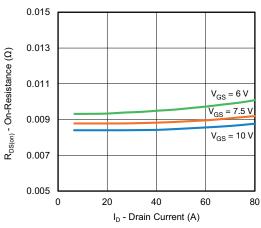
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



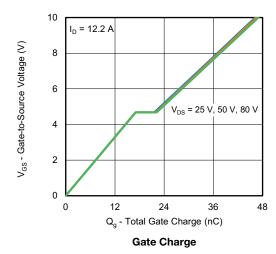
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

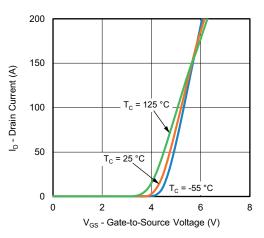


Output Characteristics

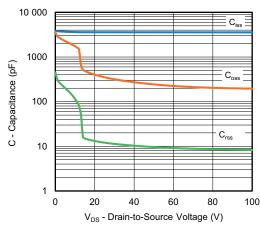


On-Resistance vs. Drain Current

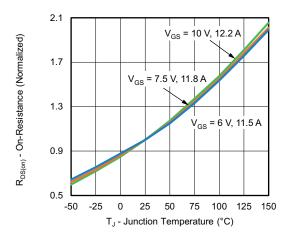




Transfer Characteristics



Capacitance

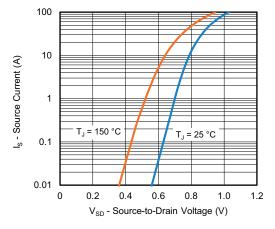


On-Resistance vs. Junction Temperature

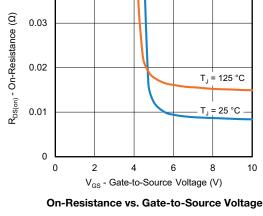
I_D = 12.2 A



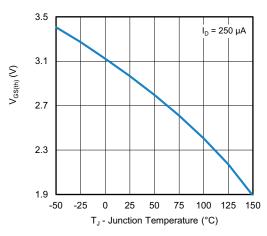
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



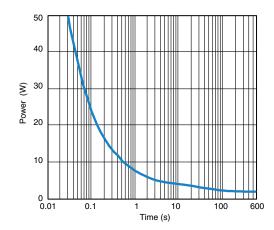
Source-Drain Diode Forward Voltage



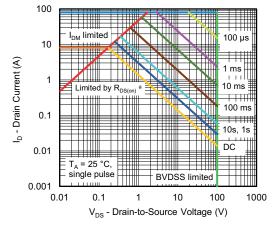
0.04



Threshold Voltage



Single Pulse Power, Junction-to-Ambient

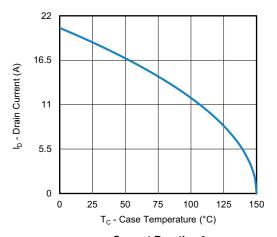


Safe Operating Area, Junction-to-Ambient

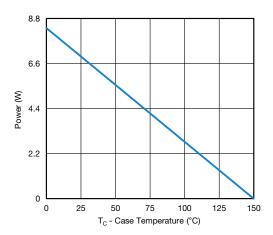
Note

a. V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

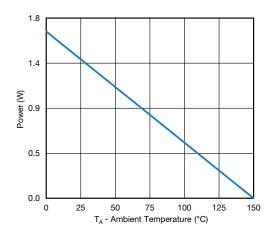
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating a



Power, Junction-to-Foot



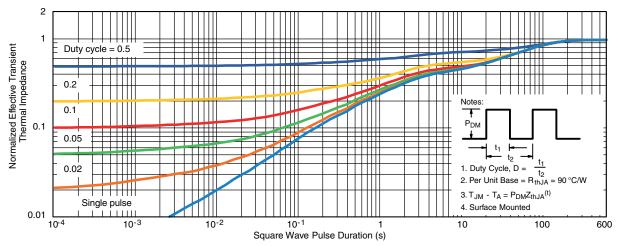
Power, Junction-to-Ambient

Note

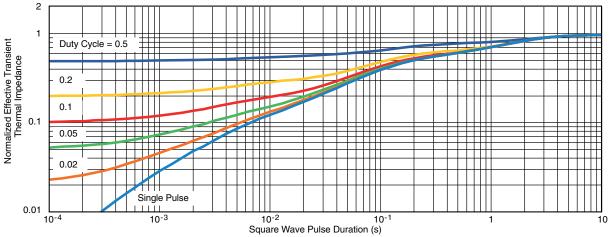
a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package / tape drawings, part marking, and reliability data, see www.vishay.com/ppg?63035.



SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIM	IETERS	INCHES			
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
Е	3.80	4.00	0.150	0.157		
е	1.27	BSC	0.050 BSC			
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Rev. I. 11-Sep-06						

DWG: 5498

Document Number: 71192 www.vishay.com 11-Sep-06

LON NOTE



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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Vishay

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